

PART NUMBER BLF404-ROC

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Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
 - Class Q Military
 - Class V Space Level

Qualified Suppliers List of Distributors (QSLD)

 Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

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As of December 7th, 2015 BL RF Power of NXP Semiconductors will operate as an independent company under the new trade name Ampleon, which will be used in future data sheets together with new contact details.

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Thank you for your cooperation and understanding,

Ampleon

UHF power MOS transistor

BLF404

FEATURES

- · High power gain
- · Easy power control
- · Gold metallization
- · Good thermal stability
- · Withstands full load mismatch
- Designed for broadband operation.

APPLICATIONS

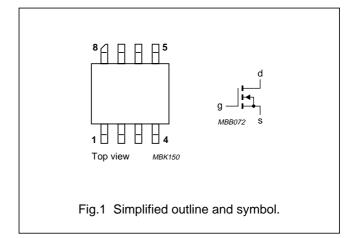
• Communication transmitters in the VHF/UHF range with a nominal supply voltage of 12.5 V.

DESCRIPTION

Silicon N-channel enhancement mode vertical D-MOS power transistor in an 8-lead SOT409A SMD package with a ceramic cap.

PINNING - SOT409A

PIN	DESCRIPTION
1, 8	source
2, 3	gate
4, 5	source
6, 7	drain



QUICK REFERENCE DATA

RF performance at $T_{mb} \le 60$ °C in a common source test circuit.

MODE OF OPERATION	f	V _{DS}	P _L	G _p	η _D
	(MHz)	(V)	(W)	(dB)	(%)
CW class-AB	500	12.5	4	≥10	≥50

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

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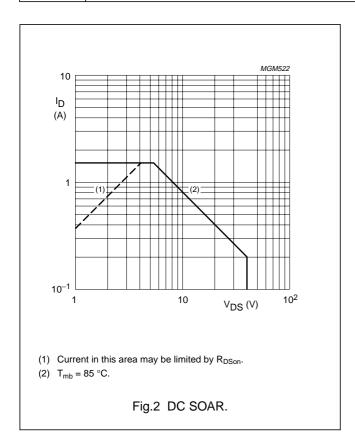
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	40	V
V_{GS}	gate-source voltage		_	±20	V
I_D	drain current (DC)		_	1.5	Α
P _{tot}	total power dissipation	T _{mb} ≤ 85 °C	_	8.3	W
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	200	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-mb}	thermal resistance from junction to mounting base	$T_{mb} \le 85 ^{\circ}C$, $P_{tot} = 8.3 W$	12.1	K/W



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CHARACTERISTICS

 $T_j = 25$ °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{GS} = 0; I_D = 5 \text{ mA}$	40	_	_	V
V_{GSth}	gate-source threshold voltage	$I_D = 50 \text{ mA}; V_{DS} = 10 \text{ V}$	2	_	4.5	V
I _{DSS}	drain-source leakage current	V _{GS} = 0; V _{DS} = 12.5 V	_	_	0.5	mA
I _{GSS}	gate-source leakage current $V_{GS} = \pm 20 \text{ V}; V_{DS} = 0$		_	_	1	μΑ
I _{DSX}	on-state drain current	ent V _{GS} = 15 V; V _{DS} = 10 V		2.3	_	Α
R _{DSon}	drain-source on-state resistance	$I_D = 0.7 A; V_{GS} = 15 V$	_	1.8	2.7	Ω
g _{fs}	forward transconductance	$I_D = 0.7 \text{ A}; V_{DS} = 10 \text{ V}$	200	270	_	mS
C _{is}	input capacitance	$V_{GS} = 0$; $V_{DS} = 12.5 \text{ V}$; $f = 1 \text{ MHz}$	_	14	_	pF
C _{os}	output capacitance	$V_{GS} = 0$; $V_{DS} = 12.5 \text{ V}$; $f = 1 \text{ MHz}$	_	17	_	pF
C _{rs}	feedback capacitance	$V_{GS} = 0$; $V_{DS} = 12.5 \text{ V}$; $f = 1 \text{ MHz}$	_	3	_	pF

V_{GS} group indicator

GROUP		IITS V)	GROUP	I	MITS V)
	MIN.	MAX.		MIN.	MAX.
А	2.0	2.1	0	3.3	3.4
В	2.1	2.2	Р	3.4	3.5
С	2.2	2.3	Q	3.5	3.6
D	2.3	2.4	R	3.6	3.7
Е	2.4	2.5	S	3.7	3.8
F	2.5	2.6	Т	3.8	3.9
G	2.6	2.7	U	3.9	4.0
Н	2.7	2.8	V	4.0	4.1
J	2.8	2.9	W	4.1	4.2
K	2.9	3.0	X	4.2	4.3
L	3.0	3.1	Y	4.3	4.4
М	3.1	3.2	Z	4.4	4.5
N	3.2	3.3			

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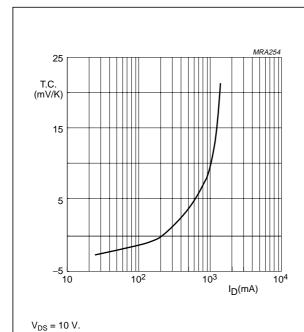
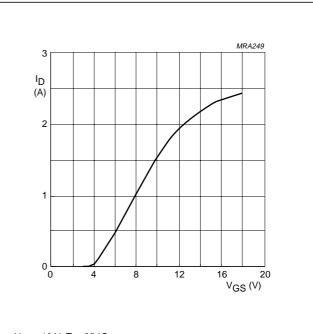


Fig.3 Temperature coefficient of gate-source voltage as a function of drain current; typical values.



 V_{DS} = 10 V; T_j = 25 °C.

Fig.4 Drain current as a function of gate-source voltage; typical values.

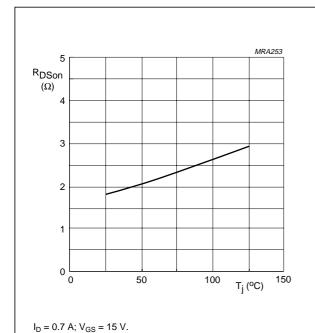
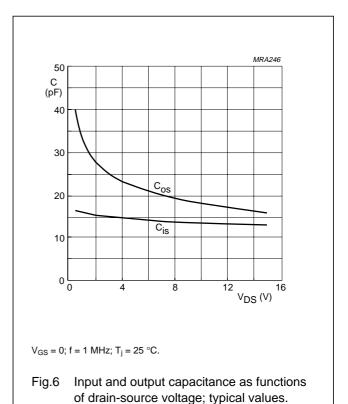


Fig.5 Drain-source on-state resistance as a function of junction temperature; typical values.

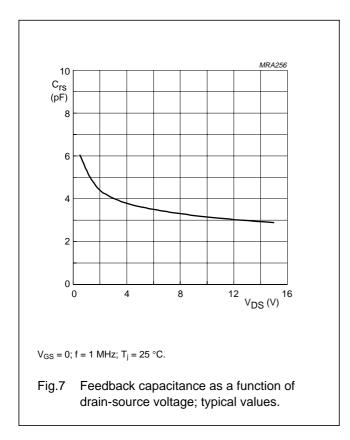


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APPLICATION INFORMATION

RF performance at $T_{mb} \le 60$ °C in a common source test circuit with the device soldered on a printed-circuit board with through metallized holes.

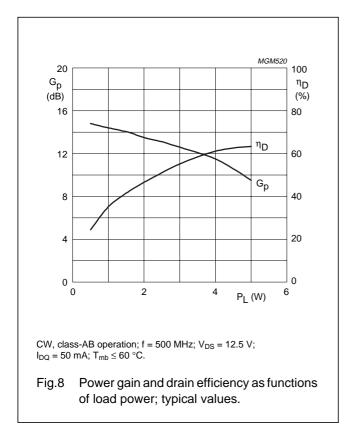
MODE OF OPERATION	f (MHz)	V _{DS} (V)	I _{DQ} (A)	P _L (W)	G _p (dB)	η _D (%)
CW, class-AB	500	12.5	50	4	≥10	≥50
					typ. 11.5	typ. 55

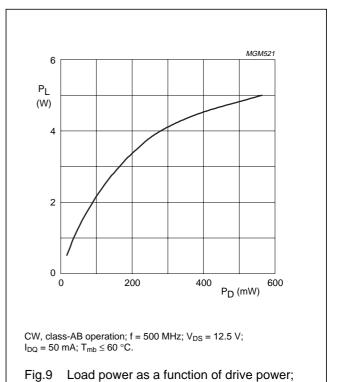
Ruggedness in class-AB operation

The BLF404 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: f = 500 MHz; $V_{DS} = 12.5$ V; $P_L = 4$ W; $T_{mb} \le 60$ °C.

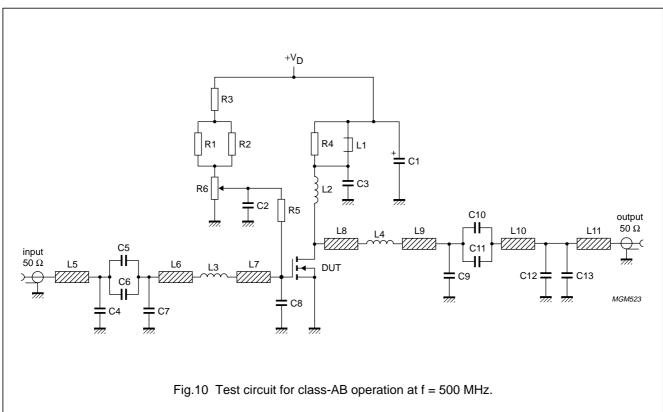
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typical values.



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List of components; see Figs 10 and 11.

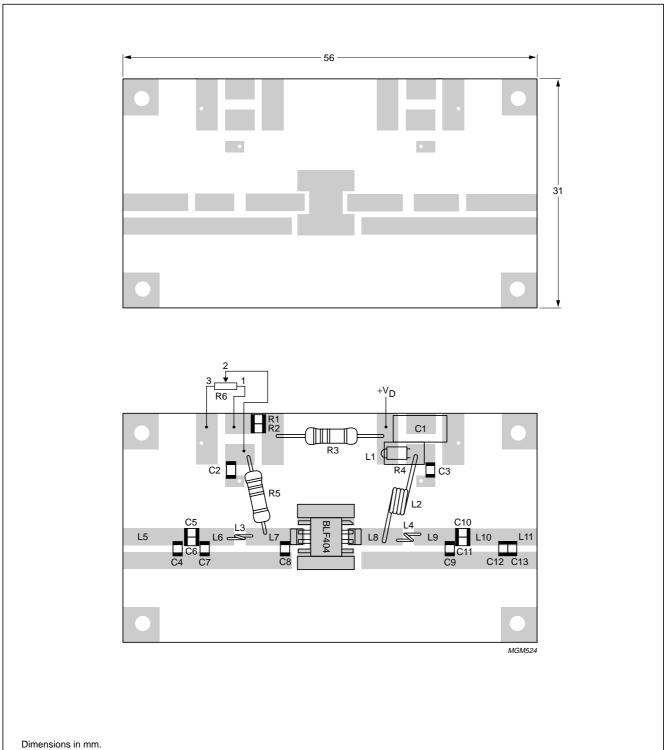
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	electrolytic capacitor	4.7 μF, 10 V		
C2, C3	multilayer ceramic chip capacitor	47 nF		
C4	multilayer ceramic chip capacitor; note 1	18 pF		
C5, C10	multilayer ceramic chip capacitor; note 1	180 pF		
C6, C11	multilayer ceramic chip capacitor; note 1	270 pF		
C7	multilayer ceramic chip capacitor; note 1	22 pF		
C8	multilayer ceramic chip capacitor; note 1	8.2 pF		
C9	multilayer ceramic chip capacitor; note 1	2.7 pF		
C12	multilayer ceramic chip capacitor; note 1	1.2 pF		
C13	multilayer ceramic chip capacitor; note 1	12 pF		
L1	2 turns 1 mm enamelled copper wire on a grade 4B1 Ferroxcube core		ext. dia. = 4.2 mm int. dia. = 2 mm length = 6 mm	
L2	3 turns 1 mm enamelled copper wire		int. dia. = 4.6 mm leads = 2 x 5 mm	
L3	bifilar coil		lead dia. = 0.8 mm	
L4	bifilar coil		lead dia. = 1 mm	
L5	stripline; note 2	50 Ω	8.8 × 2.38 mm	
L6	stripline; note 2	50 Ω	5.8 × 2.38 mm	
L7	stripline; note 2	50 Ω	6.8 × 2.38 mm	
L8	stripline; note 2	50 Ω	3.76 × 2.38 mm	
L9	stripline; note 2	50 Ω	5.8 × 2.38 mm	
L10	stripline; note 2	50 Ω	4.48 × 2.38 mm	
L11	stripline; note 2	50 Ω	3.13 × 2.38 mm	
R1, R2	SMD resistor	3.9 kΩ		
R3	metal film resistor	1 kΩ, 0.25 W		
R4	metal film resistor	22 Ω, 0.25 W		
R5	metal film resistor	10 kΩ, 0.25 W		
R6	potentiometer	10 kΩ		

Notes

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. The striplines are on a double copper-clad printed-circuit board, with DUROID dielectric (ϵ_r = 2.2); thickness 0.79 mm, thickness of the copper sheet 2 x 35 μ m.

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The components are situated on one side of the copper-clad printed-circuit board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.11 Component layout for 500 MHz class-AB test circuit.

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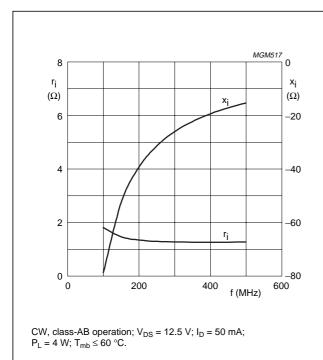


Fig.12 Input impedance as a function of frequency (series components); typical values.

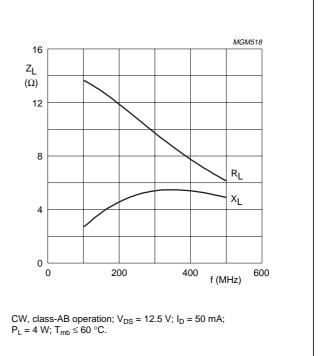
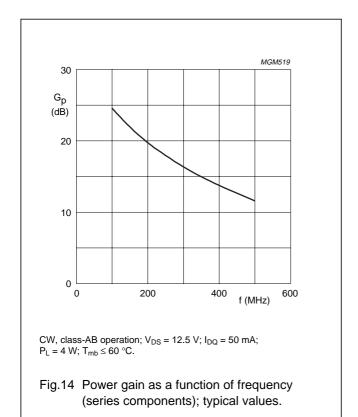


Fig.13 Load impedance as a function of frequency (series components); typical values.



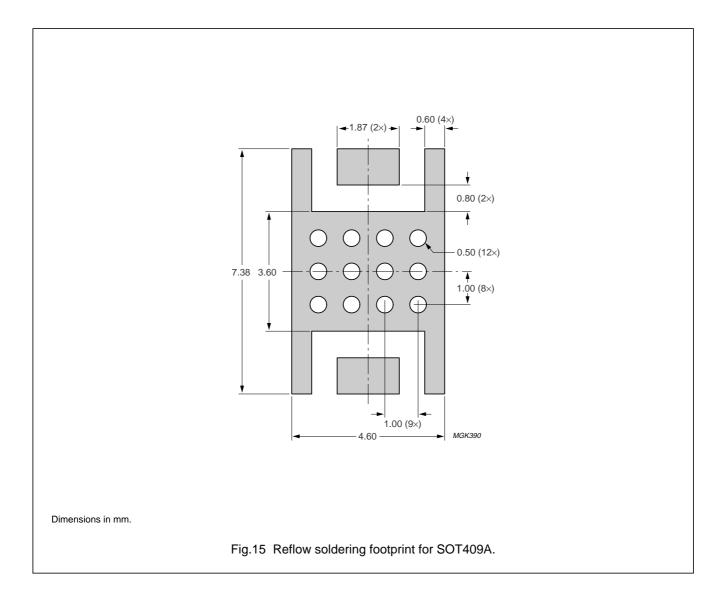
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MOUNTING RECOMMENDATIONS

Both the metallized ground plate and the device leads contribute to the heat flow. It is recommended that the transistor be mounted on a grounded metallized area of the printed-circuit board. This area should be of maximum 0.8 mm thickness and include at least 12 x 0.5 diameter through metallized holes filled with solder.

A thermal resistance $R_{th(mb-h)}$ of 5 K/W can be achieved if heatsink compound is applied when the transistor is mounted on the printed-circuit board.



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BLF404 scattering parameters

 $V_{DS} = 12.5 \text{ V}; I_D = 50 \text{ mA}; \text{ note } 1.$

f (MHz)		S ₁₁	S	21	S ₁	2	s ₂₂		
(V	s ₁₁	∠Φ	s ₂₁	∠Φ	s ₁₂	∠Φ	s ₂₂	∠Φ	
5	1.00	-5.2	12.97	176.0	0.01	86.0	0.96	-6.0	
10	0.99	-10.1	12.89	171.9	0.02	82.2	0.96	-12.0	
20	0.98	-20.6	12.61	164.1	0.03	74.8	0.95	-23.5	
30	0.96	-30.4	12.18	156.6	0.05	67.6	0.93	-34.7	
40	0.93	-39.6	11.62	149.6	0.06	60.9	0.91	-45.1	
50	0.89	-48.0	11.00	143.2	0.07	54.8	0.89	-54.7	
60	0.86	-55.8	10.37	137.4	0.08	49.4	0.87	-63.5	
70	0.83	-62.9	9.74	132.2	0.09	44.4	0.85	-71.4	
80	0.80	-69.4	9.15	127.5	0.10	40.1	0.83	-78.5	
90	0.78	-75.3	8.60	123.2	0.10	36.2	0.82	-84.8	
100	0.75	-80.7	8.08	119.3	0.10	32.7	0.80	-90.5	
125	0.71	-92.2	6.96	110.7	0.11	25.1	0.77	-102.6	
150	0.68	-101.4	6.03	103.9	0.12	19.1	0.76	-111.9	
175	0.66	-108.9	5.30	98.3	0.12	14.4	0.74	-119.2	
200	0.64	-115.2	4.73	93.2	0.12	10.2	0.74	-125.1	
250	0.63	-124.9	3.81	84.5	0.12	3.5	0.73	-134.1	
300	0.64	-132.5	3.19	77.4	0.12	-1.8	0.74	-140.5	
350	0.64	-138.6	2.70	71.2	0.11	-6.1	0.74	-145.3	
400	0.66	-143.8	2.34	65.7	0.11	-9.7	0.75	-149.1	
450	0.67	-148.4	2.03	60.5	0.10	-12.5	0.76	-152.4	
500	0.69	-152.6	1.80	56.0	0.09	-15.1	0.78	-155.2	
600	0.72	-160.2	1.44	47.7	0.08	-18.2	0.80	-159.9	
700	0.75	-167.1	1.18	40.4	0.07	-18.6	0.82	-163.9	
800	0.78	-173.6	0.99	34.4	0.05	-15.0	0.84	-167.5	
900	0.81	-179.8	0.84	29.2	0.04	-6.0	0.86	-170.7	
1000	0.83	174.3	0.73	25.1	0.04	9.9	0.88	-173.6	

Note

^{1.} For more extensive s-parameters see internet: http://www.semiconductors.philips.com/markets/communications/wirelesscommunications/broadcast

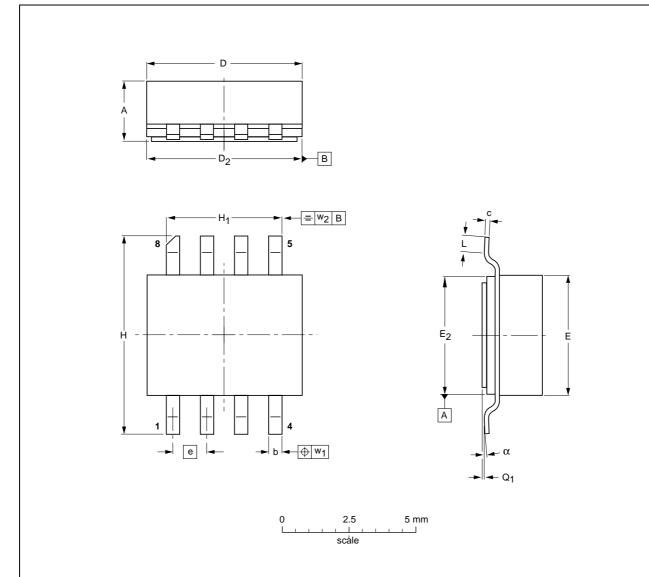
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PACKAGE OUTLINE

Ceramic surface mounted package; 8 leads

SOT409A



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	С	D	D ₂	E	E ₂	е	н	Н1	L	Q ₁	w ₁	w ₂	α
mm	2.36 2.06	0.58 0.43	0.23 0.18	5.94 5.03	5.16 5.00	4.93 4.01	4.14 3.99	1.27	7.47 7.26	4.39 4.24	1.02 0.51	0.10 0.00	0.25	0.25	7° 0°
inches	0.093 0.081	0.023 0.017	0.009 0.007	0.234 0.198	0.203 0.197	0.194 0.158	0.163 0.157	0.050	0.294 0.286	0.173 0.167	0.040 0.020	0.004 0.000	0.010	0.010	7° 0°

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT409A						98-01-27

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DATA SHEET STATUS

LEVEL	DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS(2)(3)	DEFINITION
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- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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